Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/718,146	LEURS ET AL.
Examiner	Art Unit
CHAN S. PARK	2625

SEARCHED					
Class	Subclass	Date	Examiner		
358	1.15-1.18, 1.9	12/4/2007	СР		
		-			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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DATE	1
5,112	EXMR
12/4/2007	СР